- 8-Bit Resolution
- Ratiometric Conversion
- 100- $\mu$ s Conversion Time
- 135-ns Access Time
- Guaranteed Monotonicity
- High Reference Ladder Impedance $8 \mathrm{k} \Omega$ Typical
- No Zero Adjust Requirement
- On-Chip Clock Generator
- Single 5-V Power Supply
- Operates With Microprocessor or as Stand-Alone
- Designed to Be interchangeable With National Semiconductor and Signetics ADC0803 and ADC0805



## description

The ADC0803 and ADC0805 are CMOS 8-bit, successive-approximation, analog-to-digital converters that use a modified potentiometric (256R) ladder. These devices are designed to operate from common microprocessor control buses with the 3 -state output latches driving the data bus. The devices can be made to appear to the microprocessor as a memory location or an I/O port. Detailed information on interfacing to most popular microprocessors is readily available from the factory.
A differential analog voltage input allows increased common-mode rejection and offset of the zero-input analog voltage value. Although a reference input (REF/2) is available to allow 8 -bit conversion over smaller analog voltage spans or to make use of an external reference, ratiometric conversion is possible with the REF/2 input open. Without an external reference, the conversion takes place over a span from $\mathrm{V}_{\mathrm{Cc}}$ to ANLG GND. The devices can operate with an external clock signal or with an additional resistor and capacitor, using an on-chip clock generator.
The ADC0803C and ADC0805C are characterized for operation from $0^{\circ} \mathrm{C}$ to $70^{\circ} \mathrm{C}$. The ADC0803I and ADC0805I are characterized for operation from $-40^{\circ} \mathrm{C}$ to $85^{\circ} \mathrm{C}$.

## ADC0803, ADC0805

## 8-BIT ANALOG-TO-DIGITAL CONVERTERS

WITH DIFFERENTIAL INPUTS
SLAS034 - NOVEMBER 1983 - REVISED SEPTEMBER 1986
functional block diagram (positive logic)

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

> Supply voltage, $\mathrm{V}_{\mathrm{CC}}$ (see Note 1)
> 6.5 V

> Operating free-air temperature range: ADC080_C .............................................. $0^{\circ} \mathrm{C}$ to $70^{\circ} \mathrm{C}$ ADC080_I ............................................. $-40^{\circ} \mathrm{C}$ to $85^{\circ} \mathrm{C}$
> Storage temperature range ................................................................. $-65^{\circ} \mathrm{C}$ to $150^{\circ} \mathrm{C}$
> Lead temperature $1,6 \mathrm{~mm}(1 / 16 \mathrm{inch})$ from case for 10 seconds ................................... $260^{\circ} \mathrm{C}$

NOTE 1: All voltage values are with respect to digital ground (DGTL GND) with DGTL GND and ANLG GND connected together unless otherwise noted.

## recommended operating conditions



NOTES: 2. When the differential input voltage $\left(\mathrm{V}_{\mathrm{I}_{+}}-\mathrm{V}_{\mathrm{I}}\right)$ is less than or equal to 0 V , the output code is 00000000 .
3. The internal reference voltage is equal to the voltage applied to $R E F / 2$ or approximately equal to one-half of the $V_{C C}$ when $R E F / 2$ is left open. The voltage at REF/2 should be one-half the full-scale differential input voltage between the analog inputs. Thus, the differential input voltage range when $R E F / 2$ is open and $\mathrm{V}_{\mathrm{CC}}=5 \mathrm{~V}$ is 0 V to 5 V . $\mathrm{V}_{\mathrm{REF}} / 2$ for an input voltage range from 0.5 V to 3.5 V (full-scale differential voltage of 3 V ) is 1.5 V .
4. These values are with respect to DGTL GND.
5. Total unadjusted error is specified only at an $\mathrm{f}_{\text {clock }}$ of 640 kHz with a duty cycle of $40 \%$ to $60 \%$ (pulse duration 625 ns to 937 ns ). For frequencies above this limit or pulse duration below 625 ns , error may increase. The duty cycle limits should be observed for an $\mathrm{f}_{\text {clock }}$ greater than 640 kHz . Below 640 kHz , this duty cycle limit can be exceeded provided $\mathrm{t}_{\mathrm{w}(\mathrm{CLK})}$ remains within limits.
electrical characteristics over recommended range of operating free-air temperature, $\mathrm{V}_{\mathrm{CC}}=5 \mathrm{~V}$, $\mathrm{f}_{\text {clock }}=640 \mathrm{kHz}, \mathrm{V}_{\text {REF/2 }}=2.5 \mathrm{~V}$ (unless otherwise noted)

| PARAMETER |  |  | TEST CONDITIONS |  | MIN | TYP† | MAX | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| VOH | High-level output voltage | All outputs | $\mathrm{V}_{\mathrm{CC}}=4.75 \mathrm{~V}$, | $\mathrm{IOH}=-360 \mu \mathrm{~A}$ | 2.4 |  |  | V |
|  |  | DB and INTR | $\mathrm{V}_{\mathrm{CC}}=4.75 \mathrm{~V}$, | $\mathrm{I} \mathrm{OH}=-10 \mu \mathrm{~A}$ | 4.5 |  |  |  |
| VOL | Low-level output voltage | Data outputs | $\mathrm{V}_{\mathrm{CC}}=4.75 \mathrm{~V}$, | $\mathrm{IOL}=1.6 \mathrm{~mA}$ |  |  | 0.4 | V |
|  |  | INTR output | $\mathrm{V}_{\mathrm{CC}}=4.75 \mathrm{~V}$, | $\mathrm{IOL}=1 \mathrm{~mA}$ |  |  | 0.4 |  |
|  |  | CLK OUT | $\mathrm{V}_{\mathrm{CC}}=4.75 \mathrm{~V}$, | $\mathrm{IOL}=360 \mu \mathrm{~A}$ |  |  | 0.4 |  |
| $\mathrm{V}_{\text {T+ }}$ | Clock positive-going threshold voltage |  |  |  | 2.7 | 3.1 | 3.5 | V |
| $\mathrm{V}_{\text {T- }}$ | Clock negative-going threshold voltage |  |  |  | 1.5 | 1.8 | 2.1 | V |
| $\mathrm{V}_{\mathrm{T}_{+}-\mathrm{V}_{\mathrm{T}-}}$ | Clock input hysteresis |  |  |  | 0.6 | 1.3 | 2 | V |
| ${ }_{\text {IIH }}$ | High-level input current |  |  |  |  | 0.005 | 1 | $\mu \mathrm{A}$ |
| ILL | Low-level input current |  |  |  |  | -0.005 | -1 | $\mu \mathrm{A}$ |
| Ioz | Off-state output current |  | $\mathrm{V}_{\mathrm{O}}=0$ |  |  |  | -3 | $\mu \mathrm{A}$ |
|  |  |  | $\mathrm{V}_{\mathrm{O}}=5 \mathrm{~V}$ |  |  |  | 3 |  |
| IOHS | Short-current output current | Output high | $\mathrm{V}_{\mathrm{O}}=0$, | $\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$ | -4.5 | -6 |  | mA |
| IOLS | Short-circuit output current | Output low | $\mathrm{V}_{\mathrm{O}}=5 \mathrm{~V}$, | $\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$ | 9 | 16 |  | mA |
| ICC | Supply current plus reference current |  | $\mathrm{V}_{\text {REF/2 }}=$ open, | $\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}, \quad \overline{\mathrm{CS}}=5 \mathrm{~V}$ |  | 1.1 | 1.8 | mA |
| RREF/2 | Input resistance to reference ladder |  | See Note 6 |  | 2.5 | 8 |  | $\mathrm{k} \Omega$ |
| $\mathrm{C}_{\mathrm{i}}$ | Input capacitance (control) |  |  |  |  | 5 | 7.5 | pF |
| $\mathrm{C}_{0}$ | Output capacitance (DB) |  |  |  |  | 5 | 7.5 | pF |

NOTE 6: Resistance is calculated from the current drawn from a 5-V supply applied to ANLG GND and REF/2.
operating characteristics over recommended operating free-air temperature, $\mathrm{V}_{\mathrm{CC}}=5 \mathrm{~V}$, $\mathrm{V}_{\mathrm{REF} / 2}=2.5 \mathrm{~V}, \mathrm{f}_{\text {clock }}=640 \mathrm{kHz}$ (unless otherwise noted)

| PARAMETER |  |  | TEST CONDITIONS |  | MIN | TYP† | MAX | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Supply-voltage-variation error |  |  | $\mathrm{V}_{\mathrm{CC}}=4.5$ to 5.5 V , | See Note 7 |  | +1/16 | $\pm 1 / 8$ | LSB |
| Total adusted error |  | ADC0803 | With full-scale adjust, | See Notes 7 and 8 |  |  | $\pm 1 / 4$ | LSB |
| Total unadjusted error |  | ADC0805 | $\mathrm{V}_{\mathrm{REF} / 2}=2.5 \mathrm{~V}$, | See Notes 7 and 8 |  |  | $\pm 1 / 2$ | LSB |
|  |  | VREF/2 open, | See Notes 7 and 8 |  |  | $\pm 1$ |  |
| DC common-mode error |  |  | See Notes 7 and 8 |  |  | $\pm 1 / 16$ | $\pm 1 / 8$ | LSB |
| $\mathrm{t}_{\text {en }}$ | Output enable time |  | $\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$, | $\mathrm{C}_{\mathrm{L}}=100 \mathrm{pF}$ |  | 135 | 200 | ns |
| $\mathrm{t}_{\text {dis }}$ | Output disable time |  | $\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}, \mathrm{CL}=10 \mathrm{pF}$, | $\mathrm{R}_{\mathrm{L}}=10 \mathrm{k} \Omega$ |  | 125 | 200 | ns |
| $\mathrm{t}_{\mathrm{d} \text { (INTR) }}$ | Delay time to reset INTR |  | $\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$ |  |  | 300 | 450 | nx |
| $\mathrm{t}_{\text {conv }}$ | Conversion cycle time |  | $\begin{aligned} & \mathrm{f}_{\mathrm{clock}}=100 \mathrm{kHz} \text { to } 1.46 \mathrm{MHz}, \\ & \mathrm{~T}_{\mathrm{A}}=25^{\circ} \mathrm{C}, \quad \text { See Note } 9 \end{aligned}$ |  |  |  | 73 | clock cycles |
| CR | Free-running conversion rate |  | $\overline{\text { INTR connected to } \overline{W R} \text {, }}$ | $\overline{\mathrm{CS}}$ at 0 V | 66 |  | 8770 | conv/s |

$\dagger$ All typical values are at $\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$.
NOTES: 7. These parameters are specified over the recommended analog input voltage range.
8. All errors are measured with reference to an ideal straight line through the end-points of the analog-to-digital transfer characteristics.
9. Although internal conversion is completed in 64 clock periods, a $\overline{C S}$ or $\overline{W R}$ low-to-high transition is followed by 1 to 8 clock periods before conversion starts. After conversion is complete, part of another clock period is required before a high-to-low transition of INTR completes the cycle.

PARAMETER MEASUREMENT INFORMATION


Figure 1. Read Operation Timing Diagram


Figure 2. Write Operation Timing Diagram

# ADC0803, ADC0805 <br> 8-BIT ANALOG-TO-DIGITAL CONVERTERS <br> WITH DIFFERENTIAL INPUTS <br> SLAS034 - NOVEMBER 1983 - REVISED SEPTEMBER 1986 

## PRINCIPLES OF OPERATION

The ADC0803 and ADC0805 each contain a circuit equivalent to 256-resistor network. Analog switches are sequenced by successive-approximation logic to match an analog differential input voltage ( $\mathrm{V}_{\mathrm{I}_{+}}-\mathrm{V}_{\mathrm{I}_{-}}$) to a corresponding tap on the 256R network. The most significant bit (MSB) is tested first. After eight spelled out comparisons ( 64 clock periods), an eight-bit binary code (1111 $1111=$ full scale) is transferred to an output latch and the interrupt ( $\overline{\mathrm{INTR}}$ ) output goes low. The device can be operated in a free-running mode by connecting the INTR output to the write $(\overline{\mathrm{WR}})$ input and holding the conversion start $(\overline{\mathrm{CS}})$ input at a low level. To ensure start up under all conditions, a low-level $\overline{\mathrm{WR}}$ input is required during the power-up cycle. Taking $\overline{\mathrm{CS}}$ low any time after that will interrupt a conversion in process.

When $\overline{W R}$ goes low, the internal successive-approximation register (SAR) and 8-bit shift register are reset. As long as both $\overline{\mathrm{CS}}$ and $\overline{\mathrm{WR}}$ remain low, the analog-to-digital converter remains in a reset state. One to eight clock periods after $\overline{\mathrm{CS}}$ or $\overline{\mathrm{WR}}$ makes a low-to-high transition, conversion starts.

When $\overline{\mathrm{CS}}$ and $\overline{\mathrm{WR}}$ are low, the start flip-flop is set and the interrupt flip-flop and 8-bit register are reset. The next clock pulse transfers a logic high to the output of the start flip-flop. The logic high is ANDed with the next clock pulse, placing a logic high on the reset input of the start flip-flop. If either $\overline{\mathrm{CS}}$ or $\overline{\mathrm{WR}}$ have gone high, the set signal to the start flip-flop is removed, causing it to be reset. A logic high is placed on the D input of the eight-bit shift register and the conversion process is started. If $\overline{\mathrm{CS}}$ and $\overline{\mathrm{WR}}$ are still low, the start flip-flop, the 8-bit shift register, and the SAR remain reset. This action allows for wide $\overline{\mathrm{CS}}$ and $\overline{\mathrm{WR}}$ inputs, with conversion starting from one to eight clock periods after one of the inputs goes high.

When the logic high input has been clocked through the 8-bit shift register, which completes the SAR search, it is applied to an AND gate controlling the output latches and to the D input of a flip-flop. On the next clock pulse, the digital word is transferred to the 3-state output latches and the interrupt flip-flop is set. The output of the interrupt flip-flop is inverted to provide an INTR output that is high during conversion and low when the conversion is complete.

When a low is at both $\overline{\mathrm{CS}}$ and $\overline{\mathrm{RD}}$, an output is applied to the DB0 through DB7 outputs and the interrupt flip-flop is reset. When either $\overline{\mathrm{CS}}$ or $\overline{\mathrm{RD}}$ return to a high state, the DB0 through DB7 outputs are disabled (returned to the high-impedance state). The interrupt flip-flop remains reset.

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